

## Description

The HSO2726 is the low RDSON trenched N-CH MOSFETs with robust ESD protection. This product is suitable for Lithium-ion battery pack applications.

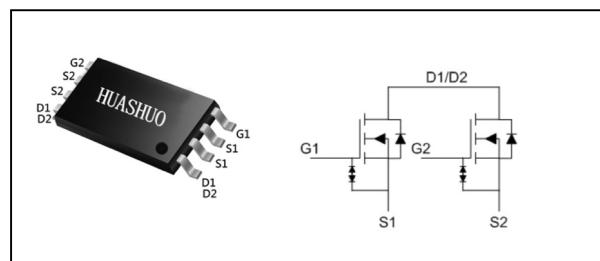
The HSO2726 meet the RoHS and Green Product requirement with full function reliability approved.

- Green Device Available
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

## Product Summary

$V_{DS}$	20	V
$R_{DS(ON),max}$	14.5	mΩ
$I_D$	7	A

## TSSOP8 Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	20	V
$V_{GS}$	Gate-Source Voltage	$\pm 12$	V
$I_D @ T_A=25^\circ C$	Continuous Drain Current <sup>1</sup>	7	A
$I_D @ T_A=70^\circ C$	Continuous Drain Current <sup>1</sup>	5.6	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	80	A
$P_D @ T_A=25^\circ C$	Total Power Dissipation <sup>3</sup>	2	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient <sup>1</sup>	---	62.5	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	20	---	---	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance <sup>2</sup>	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=3.5\text{A}$	10	12	14.5	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.0\text{V}, \text{I}_D=3.5\text{A}$	10.5	12.5	15	
		$\text{V}_{\text{GS}}=3.7\text{V}, \text{I}_D=3.5\text{A}$	11	13.5	17	
		$\text{V}_{\text{GS}}=3.1\text{V}, \text{I}_D=3.5\text{A}$	12	14	19.5	
		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_D=3.5\text{A}$	13	16	23	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}, \text{I}_D=250\mu\text{A}$	0.5	---	1.2	V
$\text{I}_{\text{DSS}}$	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=25^\circ\text{C}$	---	---	1	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=\pm 8\text{V}, \text{V}_{\text{DS}}=0\text{V}$	---	---	$\pm 10$	$\mu\text{A}$
$\text{g}_{\text{fs}}$	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=3.5\text{A}$	---	21	---	S
$\text{Q}_g$	Total Gate Charge (4.5V)	$\text{V}_{\text{DS}}=15\text{V}, \text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=7\text{A}$	---	11.2	---	$\text{nC}$
$\text{Q}_{\text{gs}}$	Gate-Source Charge		---	1.6	---	
$\text{Q}_{\text{gd}}$	Gate-Drain Charge		---	2.9	---	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time	$\text{V}_{\text{DD}}=10\text{V}, \text{V}_{\text{GS}}=4.5\text{V}, \text{R}_G=3\Omega$	---	30	---	$\text{ns}$
$\text{T}_r$	Rise Time		---	250	---	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time		---	450	---	
$\text{T}_f$	Fall Time		---	700	---	
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{DS}}=15\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{f}=1\text{MHz}$	---	850	---	$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance		---	81	---	
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		---	70	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{I}_S$	Continuous Source Current <sup>1,4</sup>	$\text{V}_G=\text{V}_D=0\text{V}$ , Force Current	---	---	7	A
$\text{V}_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_S=1\text{A}, \text{T}_J=25^\circ\text{C}$	---	---	1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 4.The data is theoretically the same as  $\text{I}_D$  and  $\text{I}_{\text{DM}}$  , in real applications , should be limited by total power dissipation.

**Typical Characteristics**



Dual N-ch 20V Fast Switching MOSFETs

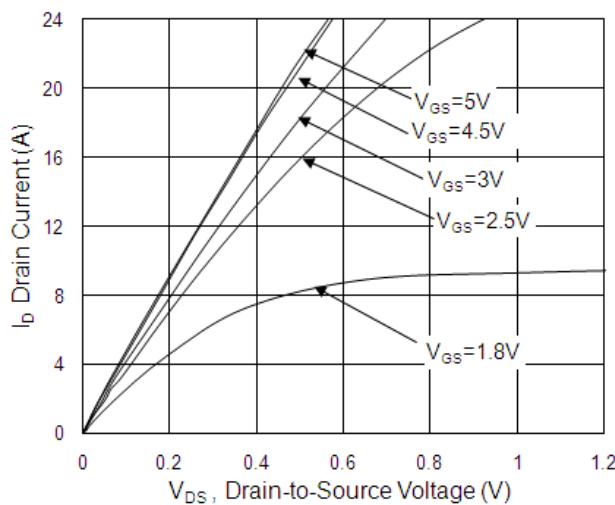


Fig.1 Typical Output Characteristics

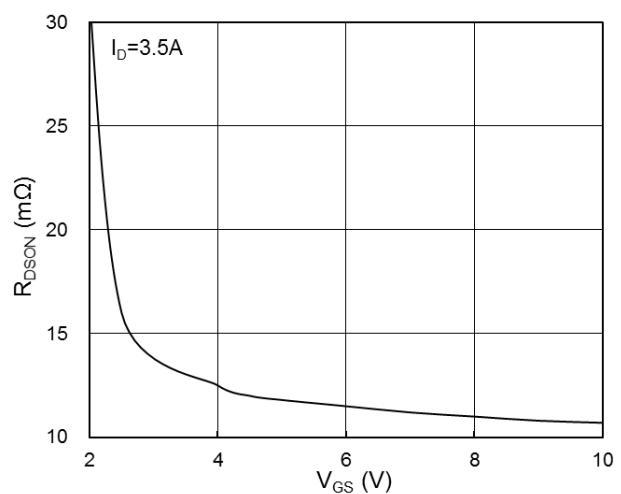


Fig.2 On-Resistance vs. Gate-Source

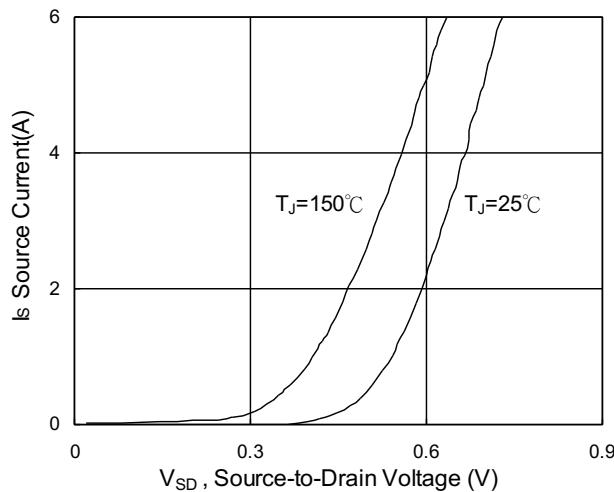


Fig.3 Forward Characteristics of Reverse

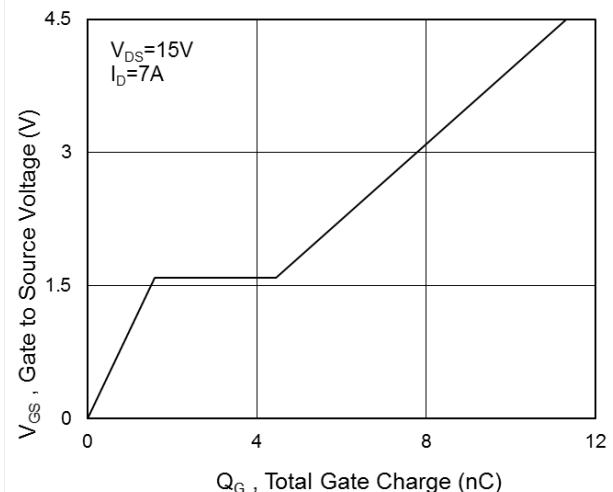


Fig.4 Gate-Charge Characteristics

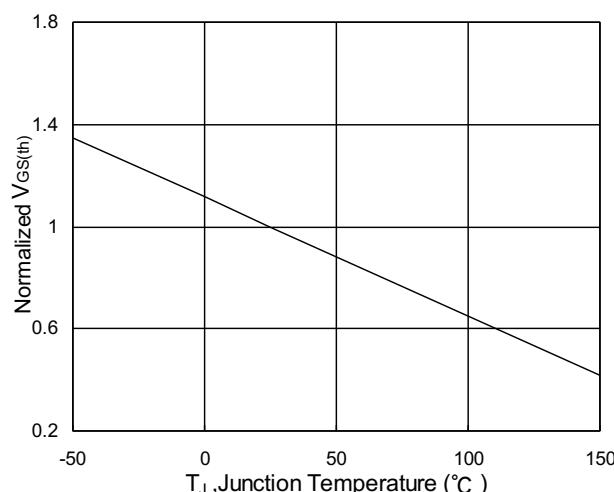


Fig.5  $V_{GS(th)}$  vs.  $T_J$

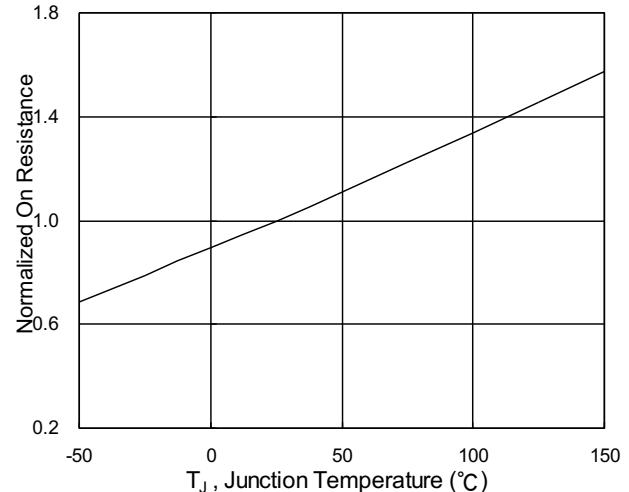


Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$



Dual N-ch 20V Fast Switching MOSFETs

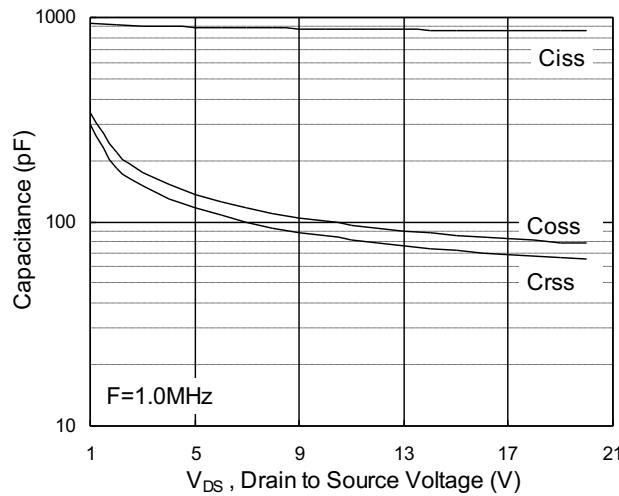


Fig.7 Capacitance

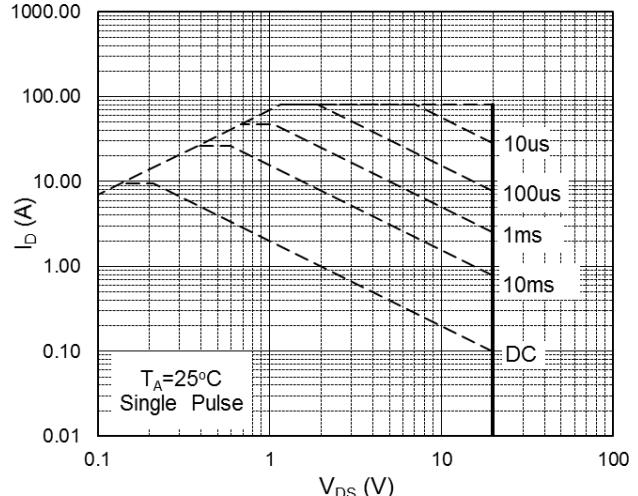


Fig.8 Safe Operating Area

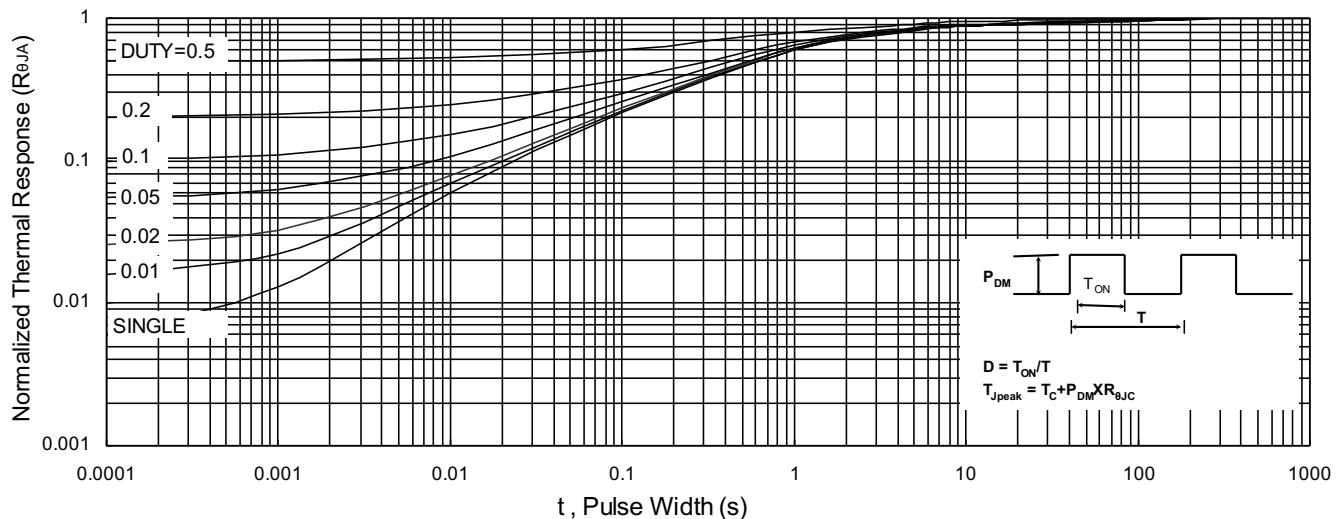


Fig.9 Normalized Maximum Transient Thermal Impedance

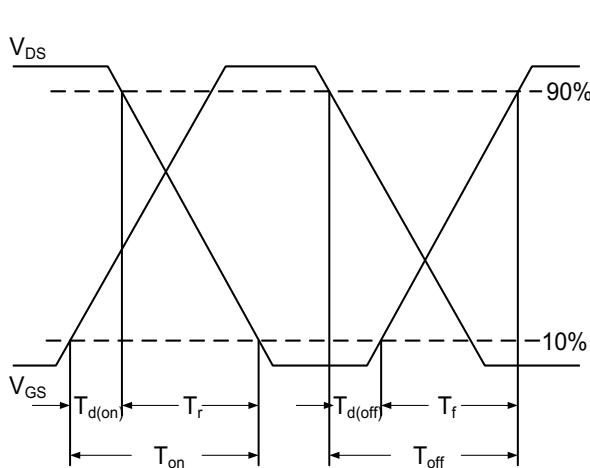


Fig.10 Switching Time Waveform

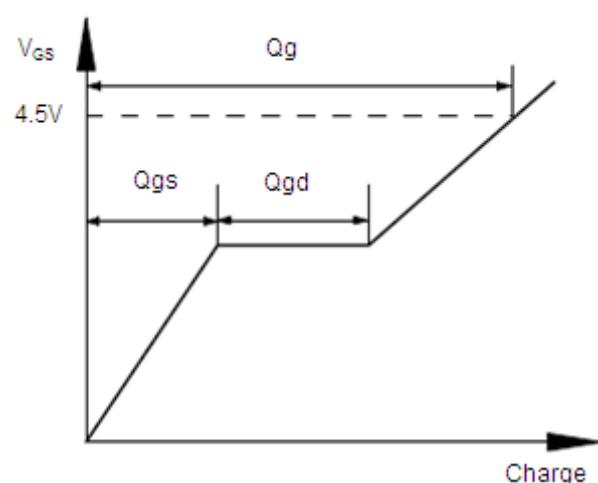
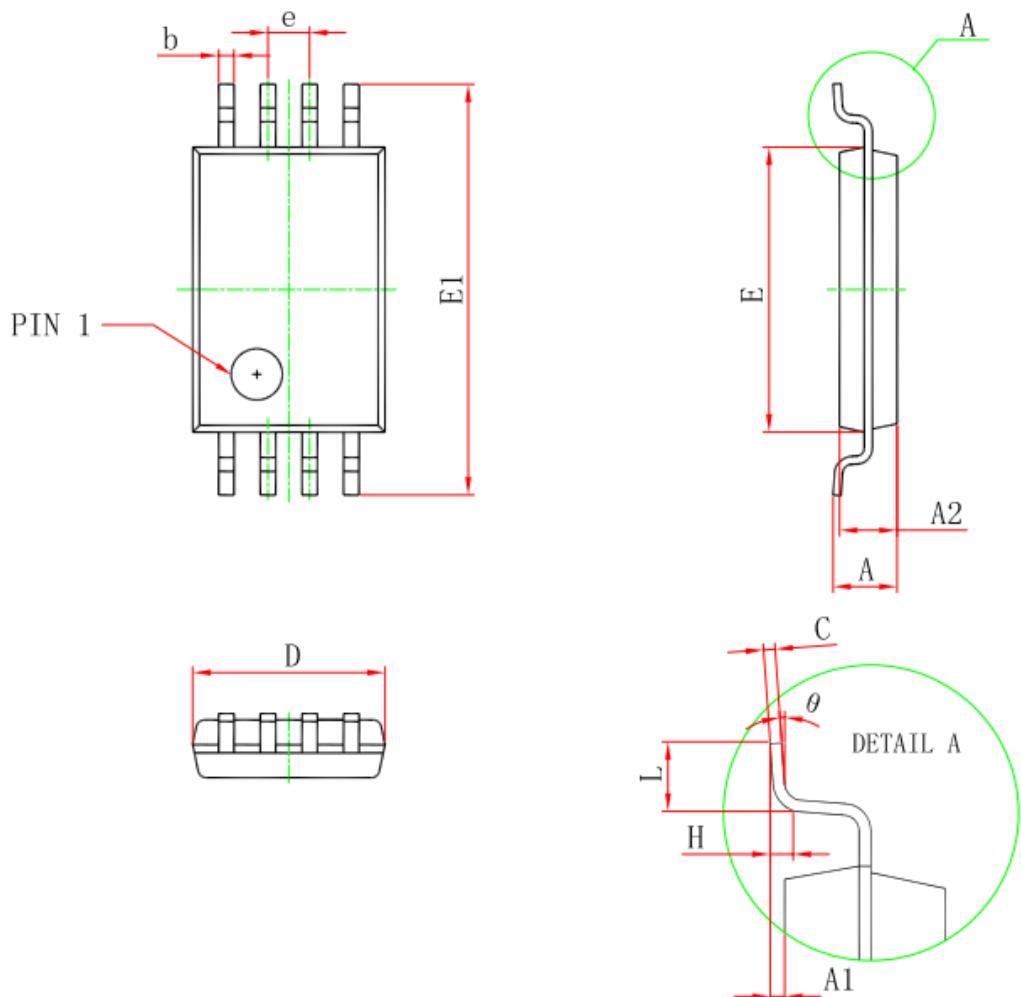


Fig.11 Gate Charge Waveform

## TSSOP8 Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
<b>D</b>	2.900	3.100	0.114	0.122
<b>E</b>	4.300	4.500	0.169	0.177
<b>b</b>	0.190	0.300	0.007	0.012
<b>c</b>	0.090	0.200	0.004	0.008
<b>E1</b>	6.250	6.550	0.246	0.258
<b>A</b>		1.200		0.047
<b>A2</b>	0.800	1.000	0.031	0.039
<b>A1</b>	0.050	0.150	0.002	0.006
<b>e</b>	0.65 (BSC)		0.026 (BSC)	
<b>L</b>	0.500	0.700	0.020	0.028
<b>H</b>	0.25(TYP)		0.01(TYP)	
<b>θ</b>	1°	7°	1°	7°

## Marking Instruction

